

**Search Notes**

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Examiner

Tam M. Nguyen

Applicant(s)/Patent under  
Reexamination

DEHAAN ET AL.

Art Unit

1764

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
see PGPUP printout		3/16/2007	TN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	3/16/2007	TN